Characteristics of left-handed multilayer slab waveguide structure

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Abstract: We examine analytically the propagation of TE-polarized waves in a four-layer slab waveguide structure. One of the layers is considered as a Left-handed or metamaterial with simultaneously negative $\varepsilon$ and $\mu$. The dispersion relation of such a structure is shown in terms of the normalized thickness and the asymmetry factors. The effect of the doubly negative material parameters on the propagation characteristics has been examined. The variation of the effective index of the structure with different parameters of the layers is studied extensively. A comparison of the structure under consideration with the conventional right handed four-layer waveguide structure is also shown.

Keywords: Left-handed materials, slab waveguide, effective index, penetration depth.

1. Introduction
The process of development of integrated optics devices may comprise four steps. First, the function of the device is defined. Second, the architecture of the structure is determined. Third, a simulation process of the device is implemented. Fourth, the device fabrication and testing are examined. In this article we examine by simulation the properties of a four-layer slab waveguide structure which forms the actual components of active or passive devices.

Much progress has been made in the studies of multilayer optical waveguide due to its high importance as a basic guiding structure in
integrated optics. Many applications have been proposed for the four-layer structure such as lens [1], large optical cavity laser [2], thin film taper coupler [3], and thin film waveguide TE-TM mode converters [4].

Recently, the concept of double-negative (negative $\varepsilon$ and negative $\mu$) materials has achieved remarkable importance due to the exhibition of unusual electromagnetic properties different from the known materials. These phenomena are observed in microwave, millimeter-wave, and optical frequency bands. The materials of double negativity are called metamaterials or Left-Handed Materials (LHMs). These are hand made structures that can be designed to exhibit specific phenomena not commonly found in nature. The LHM is a composite material in which both the electric permittivity $\varepsilon$ and the magnetic permeability $\mu$ are simultaneously negative. The history of these materials begins with the work of Veselago [5], who proposed a medium with simultaneously negative $\varepsilon$ and $\mu$ and studied the propagation of electromagnetic waves in such a medium. He predicted a number of unusual features of waves in LHMs, including negative index of refraction, the reversal of Doppler effect, and Poynting vector is antiparallel to phase velocity. Pendry et al [6] presented the artificial metallic construction of periodic rods which shows negative permittivity and they also presented a structure of split rings which exhibits a negative permittivity [7]. Smith et al [8] constructed a LHM using the combination of periodic rods and split rings and they performed many experiments in the microwave range to point out that the nature of this material is unlike any existing material. The first experimental investigation of negative index of refraction was achieved by Shelby et al in 2001 [9]. The interaction of electromagnetic waves with stratified isotropic LHMs was investigated by Kong [10]. He investigated the reflection and transmission beams, field solution of guided waves, and linear and dipole antennas in stratified structure of LHMs. The theory of LHMs and their electromagnetic properties, possible future applications, physical remarks, and intuitive justifications are provided by Engheta in 2003 [11]. Chew [12] analyzed the energy conservation property of a LHM and the realistic Sommerfeld problem of a point source over a LHM half space and a LHM slab. In 2006, Sabah et al [13] presented the reflected and transmitted powers due to the interaction of electromagnetic waves with a LHM. They studied the effects of the structure parameters, incidence angle, and the frequency on the reflected and transmitted powers for lossless LHM. The electromagnetic wave propagation through frequency-dispersive and lossy double-negative slab embedded between two different semi-infinite media was presented by Sabah et al [14]. Due to the fabrication technologies, the LHMs are widely
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used in filters, absorbers, lens, microwave components, and antennas, etc. Furthermore, many researchers continue to study the potential applications of LHMs [15-17].

In this article, we investigate analytically the propagation of electromagnetic waves in a multilayer waveguide structure. A lossless double negative slab is embedded between a semi-infinite substrate and a thin film as a guiding layer. The film is covered with a semi-infinite cladding. After examining the electric and magnetic fields using Helmholtz equation in the four layers, we study the wave penetration depth in the cladding and the substrate. The power in different layers is also derived. The effect of the doubly negative material parameters on the propagation characteristics has been examined. The variation of the effective index of the structure with different parameters of the layers is studied extensively. A comparison of the physical parameters of the proposed structure with that of the conventional right handed four-layer waveguide structure is also shown.

2. Characteristic Equation

We consider the waveguide structure shown in Fig. 1. It consists of a guiding layer with permittivity $\varepsilon_f$, permeability $\mu_f$ and thickness $d_3$. The semi-infinite substrate has permittivity $\varepsilon_s$ and permeability $\mu_s$ and the semi-infinite cladding has permittivity $\varepsilon_c$ and permeability $\mu_c$. An additional layer of Left-Handed material with negative permittivity $\varepsilon_m$, negative permeability $\mu_m$ and thickness $d_2$ is inserted between the substrate and the guiding layer. Here we assume all the materials are lossless. We also consider the TE waves in which the electric field $E$ is polarized along the y-axis. Due to the symmetry between the electric and magnetic field ($\varepsilon \leftrightarrow \mu$, $E \leftrightarrow H$), the analysis of TM modes is similar to that of TE modes.

Waves are propagating along x-axis such that $E_y \sim e^{i\beta x}$, where $\beta$ is propagation constant along x. Time harmonic fields have been assumed such that $E_y(x, z, t) = E_y(z)e^{i(\beta x - \omega t)}$. Due to the uniformity of the waveguide structure in y, the fields are uniform in y and Helmholtz equation for the electric field reduced to an ordinary linear second order differential equation, namely,

$$\frac{d^2E_y(z)}{dz^2} + (k_0^2\varepsilon_i \mu_i - \beta^2)E_y(z) = 0, \quad i \equiv s, m, f, c$$

(1)

The effective refractive index for the guiding mode $N$ is defined as $\beta = k_0N$, where $k_0 = \frac{\omega}{\sqrt{\varepsilon_0\mu_0}}$. The wave equation becomes
The waveguide structure under consideration supports a finite number of guided modes and an infinite number of unguided radiation modes. For guided mode solution, the power is required to be confined largely to the guiding layer \((\varepsilon_f, \mu_f)\). We here assume an oscillatory solution in the guiding layer such that \(\varepsilon_f \mu_f - N^2 > 0\) and an evanescent tails in all other layers \(\varepsilon_s \mu_s - N^2 < 0\), \(\varepsilon_m \mu_m - N^2 < 0\), and \(\varepsilon_c \mu_c - N^2 < 0\). The index of refraction of a given layer is \(n_i^2 = \varepsilon_i \mu_i\).

The solutions to Helmholtz equation for TE modes in the four layers are given by

\[ E_{y1}(z) = A e^{\gamma_s z}, \quad z < -d_2, \quad (3) \]
\[ E_{y2}(z) = B e^{-\gamma_s z} + G e^{\gamma_s z}, \quad -d_2 < z < 0 \]
\[ E_{y3}(z) = C \cos(\gamma_f z) + D \sin(\gamma_f z), \quad 0 < z < d_3 \]
\[ E_{y4}(z) = F e^{-\gamma_c(z-d_3)}, \quad z > d_3 \]

where \(\gamma_s = k_o \sqrt{N^2 - \varepsilon_s \mu_s}\), \(\gamma_m = k_o \sqrt{N^2 - \varepsilon_m \mu_m}\), \(\gamma_f = k_o \sqrt{\varepsilon_f \mu_f - N^2}\), \(\gamma_c = k_o \sqrt{N^2 - \varepsilon_c \mu_c}\), and the constants \(A, B, C, D, F, G\) represent the amplitudes of the wave in the layers.

It is convenient to express the characteristic equation of the optical waveguide in terms of the normalized parameters. Thus we begin by redefining the familiar normalized parameters commonly used in the three-layer case. We define a normalized thickness for layer 2 and layer 3 as

\[ V_2 = k_o d_2 \sqrt{\varepsilon_f \mu_f - \varepsilon_s \mu_s}, \quad V_3 = k_o d_3 \sqrt{\varepsilon_f \mu_f - \varepsilon_s \mu_s} \]

Layers 1 and 4 have semi-infinite thicknesses and thus need not be normalized. We also define the asymmetry factor \(a\) and the normalized index \(b\) as

\[ a = \frac{\varepsilon_s \mu_s - \varepsilon_c \mu_c}{\varepsilon_f \mu_f - \varepsilon_c \mu_c}, \quad b = \frac{N^2 - \varepsilon_s \mu_s}{\varepsilon_f \mu_f - \varepsilon_s \mu_s} \]

In addition, we introduce a new parameter which can be called the guiding ratio \([18]\),

\[ g = \frac{\varepsilon_m \mu_m - \varepsilon_s \mu_s}{\varepsilon_f \mu_f - \varepsilon_s \mu_s} \]
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![Diagram of four-layer planar waveguide structure](image)

Layer 1: Substrate ($\varepsilon_s$, $\mu_s$)
Layer 2: Left-Handed material ($\varepsilon_m$, $\mu_m$)
Layer 3: Guiding layer ($\varepsilon_f$, $\mu_f$)
Layer 4: Cladding ($\varepsilon_c$, $\mu_c$)

Fig. 1. Four-layer planar waveguide structure with layer 2 being left-handed material.

Matching the tangential components of the $E$ and $H$ fields, the characteristic equation of the structure shown in Fig. 1 can be written in terms of the above mentioned parameters as,

$$2V_3 \sqrt{1-b} - \phi_{34} - \phi_{32} = 2m\pi$$  \hspace{1cm} (10)

where $\phi_{34}$ and $\phi_{32}$ are the phase shifts at the boundaries above and below the principal guiding layer and are defined as

$$\phi_{34} = 2 \tan^{-1}\left(\frac{\mu_f}{\mu_c} \sqrt{\frac{a+b}{1-b}}\right)$$  \hspace{1cm} (11)

$$\phi_{32} = 2 \tan^{-1}\left[\frac{\mu_f}{\mu_m} \sqrt{\frac{b-g}{1-b} \frac{\sigma_+ - \sigma_- e^{-2V_3 V_5 (b-g)}}{\sigma_+ + \sigma_- e^{-2V_3 V_5 (b-g)}}}\right]$$  \hspace{1cm} (12)

where $\sigma_+ = 1 + \frac{\mu_m}{\mu_s} \sqrt{\frac{b}{b-g}}$ and $\sigma_- = 1 - \frac{\mu_m}{\mu_s} \sqrt{\frac{b}{b-g}}$.

3. Penetration Depth

The effective guide thickness is an important factor in the dispersion of the effective refractive index and in the application of optical sensing. Foreknowing this, we first calculate the effective guide thickness from the ray penetrations at the upper and lower boundaries of the guiding layer. The
penetration of the guided wave from the guiding layer into the surrounding media can be written as [19]

\[
x_2 = \frac{1}{2k_0N} \left( \frac{\partial \phi_{12}}{\partial \gamma} \right) \\
x_4 = \frac{1}{2k_0N} \left( \frac{\partial \phi_{34}}{\partial \gamma} \right)
\]

where \( N = \sqrt{\varepsilon \mu_f \sin(\gamma)} \) and \( \gamma \) is the angle a ray makes with the normal to the boundary as shown in Fig. 2. In terms of the penetrations \( x_2 \) and \( x_4 \), the effective guide thickness is given by

\[
d_{\text{eff}} = d_1 + x_2 + x_4
\]

and the normalized effective guide thickness can be written as

\[
V_i' = k_0d_{\text{eff}} \sqrt{\varepsilon \mu_f - \varepsilon \mu_s}
\]

Calculating the derivatives in Eqs. (13) and (14), we get

\[
x_2 = \frac{\mu_f \sqrt{\varepsilon \mu_f - N^2} \left( \frac{b - g}{1-b} q_3 + q_2 \sigma \right)}{\mu_m k_0 N (1 + \frac{\mu_f^2}{\mu_m^2} \frac{(b - g) \sigma^2}{(1-b)})} \\
x_4 = \frac{\mu_f (1+a)}{\mu_m k_0 (1-b) (1 + \frac{\mu_f^2}{\mu_m^2} \frac{(a+b) \sigma^2}{(1-b)}) \sqrt{N^2 - \varepsilon \mu_s}}
\]

where \( \sigma = \frac{\sigma_1}{\sigma_2} \), \( \sigma_1 = \sigma_+ - \sigma_- e^{-2V_2 \sqrt{b-g}} \), \( \sigma_2 = \sigma_+ + \sigma_- e^{-2V_2 \sqrt{b-g}} \),

\[
q_2 = \frac{1-b}{b-g} \frac{N(1-g)}{(1-b)^2 (\varepsilon \mu_f - \varepsilon \mu_s)}, \quad q_3 = -\frac{\sigma_2 (q + q_1) - \sigma_1 (q_1 - q)}{\sigma_2^2}, \\
q = \frac{\mu_m}{\mu_s} \sqrt{\frac{b-g}{(b-g)^2 (\varepsilon \mu_f - \varepsilon \mu_s)}}, \quad q_1 = e^{-2V_2 \sqrt{b-g}} (q - \frac{2V_2 \mu_s}{\sqrt{b-g} (\varepsilon \mu_f - \varepsilon \mu_s)})
\]
4. Power flow through the waveguide layers

In this section we derive the power carried by each layer to fully investigate the four-layer waveguide properties when one of the layers is considered to exhibit a negative index of refraction. The guided wave power per unit length along x-axis is given by

\[ P_{\text{total}} = \frac{Nk_e}{20\mu} \int_{-\infty}^{\infty} E_y^2(z) dz \] \tag{19} 

where \( \omega \) is the angular frequency. Using Eqs. (3)-(6) to calculate the integral given by Eq. (19), we obtain

\[ P_1 = \frac{Nk_eA^2d_3}{4\alpha\mu V_1\sqrt{b}} \] \tag{20} 

\[ P_2 = \frac{Nk_e d_3}{4\alpha\mu V_1\sqrt{b - g}} (-B^2(1 - e^{2V_2\sqrt{b - g}}) + G^2(1 - e^{-2V_2\sqrt{b - g}}) + 4BGV_2\sqrt{b - g}) \] \tag{21} 

\[ P_3 = \frac{Nk_e d_3}{4\alpha\mu V_3\sqrt{1/b}} \{C^2S_+ + D^2S_- + CD[1 - \cos(2V_3\sqrt{1/b})]\} \] \tag{22} 

\[ P_4 = \frac{Nk_eE^2d_3}{4\alpha\mu V_3\sqrt{a + b}} \] \tag{23}
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where \( S_+ = V_3 \sqrt{1 - b} + \frac{1}{2} \sin(2V_3 \sqrt{1 - b}) \) and \( S_- = V_3 \sqrt{1 - b} - \frac{1}{2} \sin(2V_3 \sqrt{1 - b}) \)

When the continuity requirement is applied to Eqs. (3)-(6) and their derivatives, the following relations between the constants \( A, B, C, D, F, G \) are obtained

\[
G = \frac{1}{2} A e^{V_3 \sqrt{1 - b}} \left( 1 + \frac{\mu_m}{\mu_s} \sqrt{\frac{b}{b - g}} \right) 
\]

\[
B = \frac{1}{2} A e^{-V_3 \sqrt{1 - b}} \left( 1 - \frac{\mu_m}{\mu_s} \sqrt{\frac{b}{b - g}} \right) 
\]

\[
C = B + G 
\]

\[
D = \frac{\mu_f}{\mu_m} \sqrt{\frac{b - g}{b - 1}} (-B + G) 
\]

\[
F = C \cos(V_3 \sqrt{1 - b}) + D \sin(V_3 \sqrt{1 - b}) 
\]

5. Discussion

We have carried out the computations of the effective refractive index as a function of the guiding layer thickness \( d_3 \), the thickness of the LHM layer \( d_2 \) and the penetration depths \( x_2 \) and \( x_4 \). In our calculations we suppose the cladding to have the lowest refractive index and the guiding layer to have the highest one, \( \mu_m = -1 \) and \( \lambda = 630 \text{nm} \). Fig. 3 shows the variation of the effective refractive index with \( d_3 \). As \( d_3 \) approaches the cutoff thickness, the effective index approaches the substrate index \( n_s \) since in this limit all the power of the mode propagates in the substrate. The guided mode probes the substrate side only. As \( d_3 \) increases the confinement of the guided wave increases and the effective index approaches the guiding layer index \( n_f \). For a given \( d_3 \), the effective index increases as \( n_f \) increases. Fig. 4 shows a comparison between the conventional four-layer waveguide with all the refractive indices being positive and the structure under consideration (i.e. Layer 2 is a LHM). It is clear that for a given \( d_3 \) and \( n_f \), the conventional waveguide has a higher effective index. This behavior can be interpreted as: the evanescent wave generated at the boundary between the guiding layer and the LHM layer excites a surface wave at the boundary between the LHM layer and the substrate [20,21]. This effect enhances the field in the substrate so that the effective index decreases in the structure under consideration when compared with the case of four positive-index layers. The effective index as a function of layer 2 thickness \( d_2 \) (thickness of the LHM layer) is shown in Fig. 5. In contrary to its behavior with \( d_3 \), the effective index decreases with increasing \( d_2 \). Fig. 6 shows that the effective
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index decreases with increasing the penetration depths $x_2$ and $x_4$ and that it is very sensitive to the penetration depth $x_4$ in the cladding medium. This means that the structure under consideration is an eligible candidate for optical sensing applications.

Fig. 3. Effective refractive index versus the guiding layer thickness for $n_s = 1.55$, $n_e = 1.33$, $n_m = -1.65$, $d_2 = 100\text{nm}$, $n_f = 1.8$ (solid line), $n_f = 1.9$ (dotted line), and $n_f = 2$ (dashed line).

Fig. 4. Effective refractive index versus the guiding layer thickness for $n_s = 1.55$, $n_e = 1.33$, $n_m = -1.65$, $d_2 = 100\text{nm}$, for different values of $n_f$. The dashed lines represent the case when layer 2 is an ordinary dielectric with positive index and the solid lines represent the case when it is LHM.

Fig. 5. Effective refractive index versus the thickness of layer 2 for $n_s = 1.55$, $n_e = 1.33$, $n_m = -1.65$, $n_f = 2$, $d_j = 100\text{nm}$ (solid line), $d_3 = 150\text{nm}$ (dotted line), and $d_3 = 200\text{nm}$ (dashed line).

Fig. 6. Effective refractive index versus the penetration depths $x_2$ (solid line) and $x_4$ (dotted line) for $n_s = 1.55$, $n_e = 1.33$, $n_m = -1.65$, $d_2 = 100\text{nm}$, $n_f = 1.8$ and $d_3 = 400\text{nm}$.
The electric field configuration for the proposed structure is shown in Figs 7 and 8. As can be seen as the thickness of the LHM $d_2$ is increased from 50nm in Fig. 7 to 100nm in Fig. 8, two maxima arise in the field configuration. Thus the guided wave is supported by both of layer 2 and layer 3. Also we notice that the evanescent field strength in the cladding is higher in Fig. 8 ($d_3 = 120\text{nm}$) than that in Fig. 7 ($d_3 = 100\text{nm}$).

The powers $P_2$ in Layer 2, $P_3$ in the guiding layer, and $P_4$ in the cladding as functions of the thickness of the LHM layer ($d_2$) are shown in Fig. 9. As $d_2$ increases $P_2$ of the LHM increases while the power $P_4$ in the clad decreases. The power $P_2$ increases on expense of the cladding power. When the LHM layer thickness increases, the power concentrates in that layer because it becomes more bulky and nearly guiding. The powers $P_1$ in the substrate, $P_2$ in Layer 2, $P_3$ in the guiding layer, and $P_4$ in the cladding as functions of the guiding layer thickness ($d_3$) are shown in Figs. 10-13. For small values of $d_3$ (near cut-off thickness) most of the power flows in the substrate ($P_1$), and the powers $P_2$ and $P_3$ have minimum values. As $d_3$ increases, $P_1$ decreases and both $P_2$ and $P_3$ increase due to the guidance of the wave in these two layers. The power $P_4$ in the cladding has the minimum value among the other powers since the refractive index of this layer has the lowest value. To increase $P_4$ (power flow in cladding) for some applications such as optical sensing, a reverse asymmetry configuration is suggested. In this configuration, the index of the cladding is taken to be greater than that of the substrate. In this case, the part $P_4$ of the power increases and the part $P_1$ of the power decreases. Fig. 14 shows the fraction of total power flowing in the cladding as a function of the guiding layer refractive index $n_f$ for different values of the refractive index of the LHM $n_m$. This fraction decreases with increasing the guiding layer refractive index due to the increase of the wave confinement in the guiding layer. For a given value of $n_f$, this fraction can be enhanced by increasing the absolute value of the refractive index of layer 2 (LHM).
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Fig. 7. Electric field configuration for $n_s = 1.55$, $n_r = 1.33$, $n_m = -1.65$, $n_f = 2$, $d_2 = 50\text{nm}$, and $d_3 = 100\text{nm}$.

Fig. 8. Electric field configuration for $n_s = 1.55$, $n_r = 1.33$, $n_m = -1.65$, $n_f = 2$, $d_2 = 100\text{nm}$, and $d_3 = 120\text{nm}$.

Fig. 9. Powers $P_2$ (dashed), $P_3$ (dotted), and $P_4$ (solid) versus the thickness of layer 2 for $n_s = 1.55$, $n_r = 1.33$, $n_m = -1.82$, $n_f = 2$, $d_3 = 150\text{nm}$.

Fig. 10. Power flow in the substrate $P_1$ as a function of the guiding layer thickness for $n_s = 1.55$, $n_r = 1.33$, $n_m = -1.82$, $d_2 = 100\text{nm}$, and $n_f = 2$. 
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Fig. 11. Power flow in the layer 2 (LHM) $P_2$ as a function of the guiding layer thickness for $n_s = 1.55$, $n_c = 1.33$, $n_m = -1.82$, $n_f = 2$, and $d_2 = 100$nm.

Fig. 12. Power flow in the guiding layer $P_3$ as a function of the guiding layer thickness for $n_s = 1.55$, $n_c = 1.33$, $n_m = -1.82$, $n_f = 2$, and $d_2 = 100$nm.

Fig. 13. Power flow in the cladding $P_4$ as a function of the guiding layer thickness for $n_s = 1.55$, $n_c = 1.33$, $n_m = -1.82$, $n_f = 2$, and $d_2 = 100$nm.

Fig. 14. Fraction of total power flowing in the cladding as a function of the guiding layer refractive index for $n_s = 1.55$, $n_c = 1.33$, $n_m = -1.55$ (solid line), $n_m = -1.6$ (dotted line), and $n_m = -1.65$ (dashed line).

6. Conclusion

In conclusion, we have analyzed a four-layer waveguide in which one of the layers is a left-handed material (LHM) of simultaneously negative $\varepsilon$ and $\mu$. The behavior of the effective refractive index with different parameters of the structure is studied and analyzed. The electric field configuration in such a structure is shown for different cases. The power flow in through the waveguide structure is also shown. We believe that structures containing LHMs can improve the performance of various slab waveguide devices.
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